INFORMATION Halide free

PRODUCT No. : Q13MC1462000100

MODEL :

MC-146

32.768 kHz 7 pF ± 20

INFO. No. : Q09-282-22A

DATE : Mar. 10. 2010

EPSON TOYOCOM CORPORATION

8548 Naka-minowa Minowa-machi Kamiina-gun Nagano-ken 399-4696 Japan

INTRODUCTION

- 1. The contents is subject to change without notice. Please exchange the specification sheets regarding the product's warranty.
- 2. This sheet is not intended to guarantee or provide an approval of implementation of industrial patents.
- 3. We have prepared this sheet as carefully as possible. If you find it incomplete or unsatisfactory in any respect, We would welcome your comments.

1) RoHS compliant

MC-146 contains lead in high melting type solder which is exempted in RoHS directive.

- 2) This Product supplied (and any technical information furnished, if any) by Epson Toyocom Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes. Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.
- 3) This product listed here is designed as components or parts for electronics equipment in general consumer use. We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an systems, and medical equipment, the functional purpose of which is to keep extra high reliability, such as satellite, rocket and other space life.

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1

[1] Absolute maximum ratings

			Rating value				
No.	Item	Symbol	Min.	Тур.	Max.	Unit	Note
1	Storage temperature range	T_stg	- 55		+ 125	°C	Suppose to be within CI STD at $+ 25 \text{ °C} \pm 3 \text{ °C}$.
2	Maximum level of drive	GL		1.0		μW	

[2] Operating range

			R	Rating value			
No.	Item	Symbol	Min.	Тур.	Max.	Unit	Note
1	Operating temperature range	T_use	- 40		+ 85	°C	
2	Level of drive	DL	0.01	0.1	0.5	μW	
3	Vibration mode		Fundamental				

[3] Static characteristics

No.	Item		Symbol	Value	Unit	Conditions
1	Nominal Frequency		f_nom	32.768	kHz	
2	Frequency tolerance		f_tol	± 20	× 10 ⁻⁶	CL = 7 pF Ta = + 25 ± 3 °C Level of drive : 0.1 μ W Not include aging
3	Motional resistance		R1	65 Max.	kΩ	
4	Motional capacitance		C1	1.9 Тур.	fF	CI meter : Saunders 140B Level of drive : 0.5 µW
5	Shunt capacitance		CO	0.8 Typ.	pF	
6	Frequency temperature	Turnover temperature	Ti	$+ 25 \pm 5$	°C	Values are calculated by The frequencies
	characteristics	Derchalia		$\times 10^{-6}$ /°C ²	at $+ 10$, $+ 25$, $+ 40 \degree$ C with C-MOS circuit.	
7	7 Isolation resistance		R	500 Min.	ΜΩ	DC 100 V ± 15, 60 seconds Between terminal # 1 and terminal # 2
8	Frequency Aging		f_age	± 3	$\times 10^{-6}$ /year	$Ta = +25 \text{ °C} \pm 3 \text{ °C}$ Level of drive : 0.1 µW

[4] Environmental and Mechanical characteristics

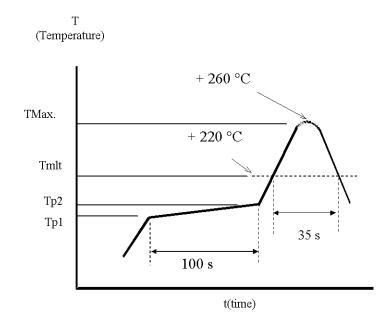
No.	Items		Value	*1*2	Conditions
1	Shock	*3	$\frac{\Delta f/f [1 \times 1]}{\pm 5}$		100 g dummy (EPSON TOYOCOM Standard) drop from 1500 mm height on to the concrete 3 directions 10 times
2	Vibration	*3	±3		10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz \rightarrow 500 Hz \rightarrow 10 Hz 15 min./cycle 6 h (2 hours , 3 directions)
3	Resistance to soldering heat (Reflow characteristics)	*3	± 5		Treat the Reflow 2 times by the following profile in the next page
4	High temperature storage	*3	a)±20 b)±10		a) + 125 °C × 1 000 h b) + 85 °C × 1 000 h
5	Low temperature storage	*3	± 10		- 55 °C × 1 000 h
6	Temperature humidity storage	*3	± 10		+ 85 °C × 85 %RH × 1000 h
7	Temperature cycle	*3	±10		 - 55 °C ↔ + 125 °C 30 minutes at each temperature 100 cycles
8	Shear		No peeling-o soldered j		10 N press the side for 10 s ±1 s. Ref. IEC 60068-2-21
9	Pull-off		No peeling-o soldered j		10 N press the side for 10 s ±1 s. Ref. IEC 60068-2-21
10	Substrate bending		No peeling-o soldered j		Bending width reaches 3mm and hold for 5 s \pm 1 s \times 1 time Ref. IEC 60068-2-21
11	Solderability		nination mus ered with fres		Dip termination into solder bath at $+ 235 \pm 5$ °C for 3 s (Using rosin flux)
12	Solvent resistance		The marking : legible		Ref. ЛS C 0052 or IEC 60068-2-45

Note 1. *1 Each test done independently.

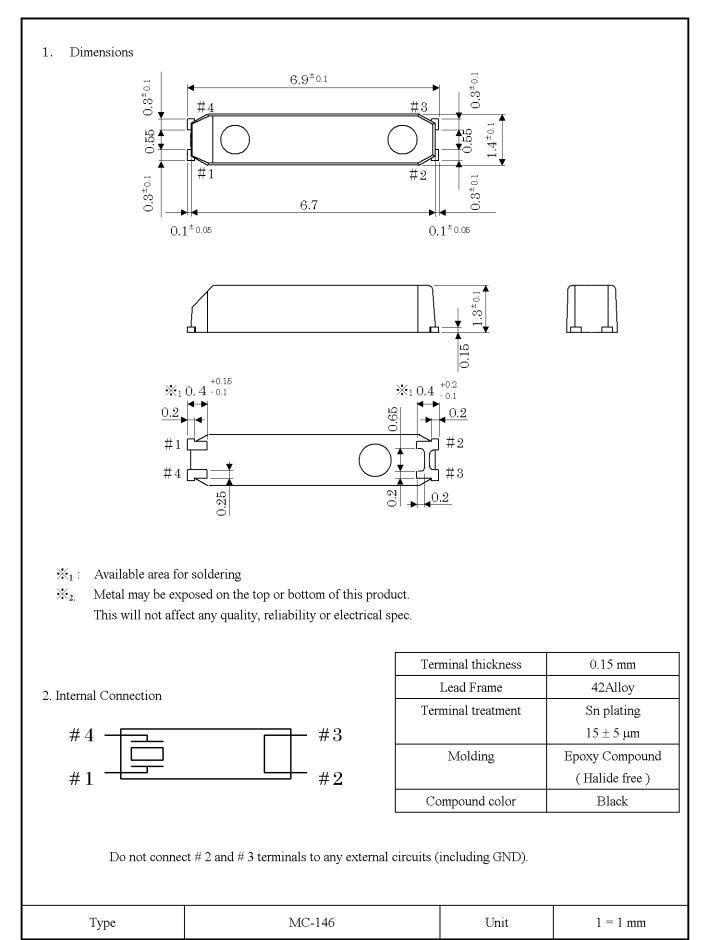
- 2. *2 Measuring 1 h to 24 h later leaving in room temperature after each test.
- 3. *3 Pre conditionings
 - 1. + 125 °C \times 24 h to +85 °C \times 85 %RH \times 48 h \rightarrow reflow 2 times
 - 2. Initial value shall be after 24 h at room temperature.
- 4. Shift series resistance at after above tests should be less than \pm 15 % or less than \pm 5 k Ω In case Resistance to soldering heat, high temperature storage (\pm 125 °C $\times 1$ 000 h) shift series resistance at after above tests should be less than \pm 20 % or \pm 10 k Ω

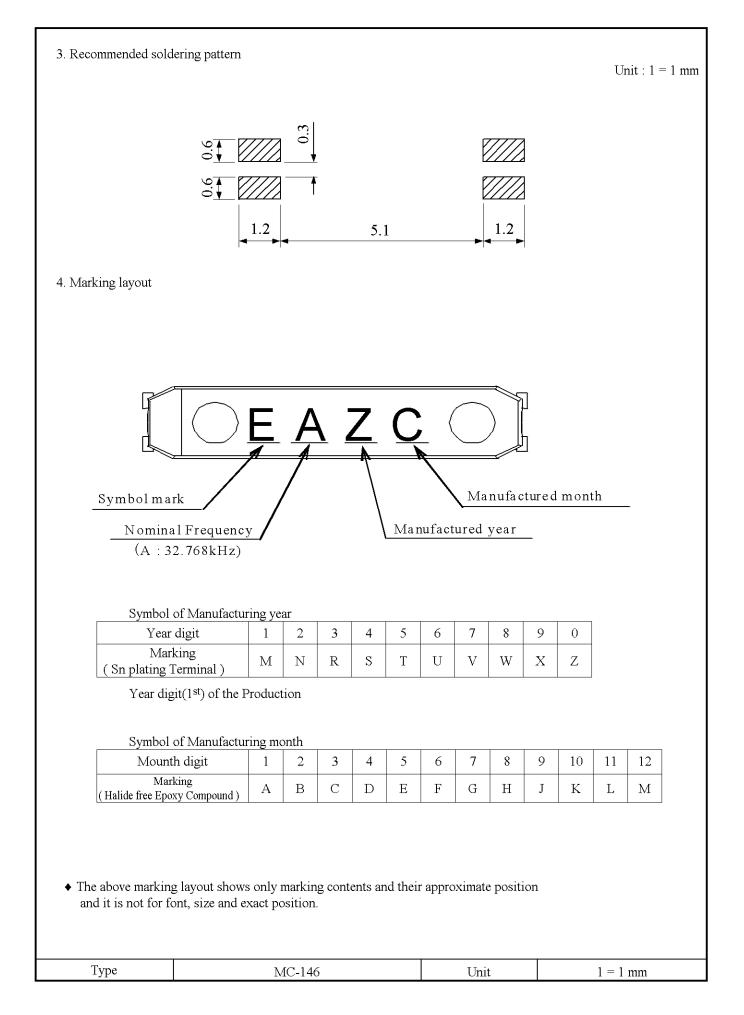
♦ Air- reflow

Pre heating temperature : Tp1 \sim Tp2 = + 170 °C Peak temperature must not exceed + 260 °C and the duration of over + 220 °C should be 35 s



[5] Dimensions and Marking layout

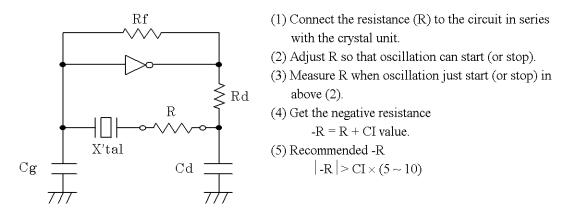




[6] Notes

- 1. Max two (2) times reflow is allowed. Once miss soldering is happened, hand work soldering by soldering iron is recommended. (+ 350 °C × within 5 sec.)
- 2. Patterning should be followed by our recommended one.
- 3. Applying excessive excitation force to the crystal unit may cause deterioration damage.
- 4. Unless adequate negative resistance is allocated in the oscillation circuit, start up time of oscillation may be increased, or no oscillation may occur.

How to check the negative resistance.



- The shortest patterning line on board is recommendable. Too long line on board may cause of abnormal oscillation.
- To avoid mull function, no pattern under or near the crystal is allowed. Solder paste should be more than 150 μm thickness.
- 7. This device must be stored at the normal temperature and humidity conditions before mounting on a board.
- Too much exciting shock or vibration may cause deterioration on damage.
 Depending on the condition such as a shock in assembly machinery, the products may be damaged.
 Please check your condition in advance to maintain shock level to be smallest.
- 9. Depending on the conditions, ultrasonic cleaning may cause resonant damage of the internal crystal unit. Since we are unable to determine the conditions (type of cleaning unit, power, time, conditions inside the bath, etc.) to be used in your company, we cannot guarantee the safety of this unit when it is cleaned in an ultrasonic cleaner.
- 10. Ink marking may be damaged by some kind of solvent, please take precautions when choosing solvent by your selves.
- 11. Please refer to packing specification regarding how to storage the products in the pack.

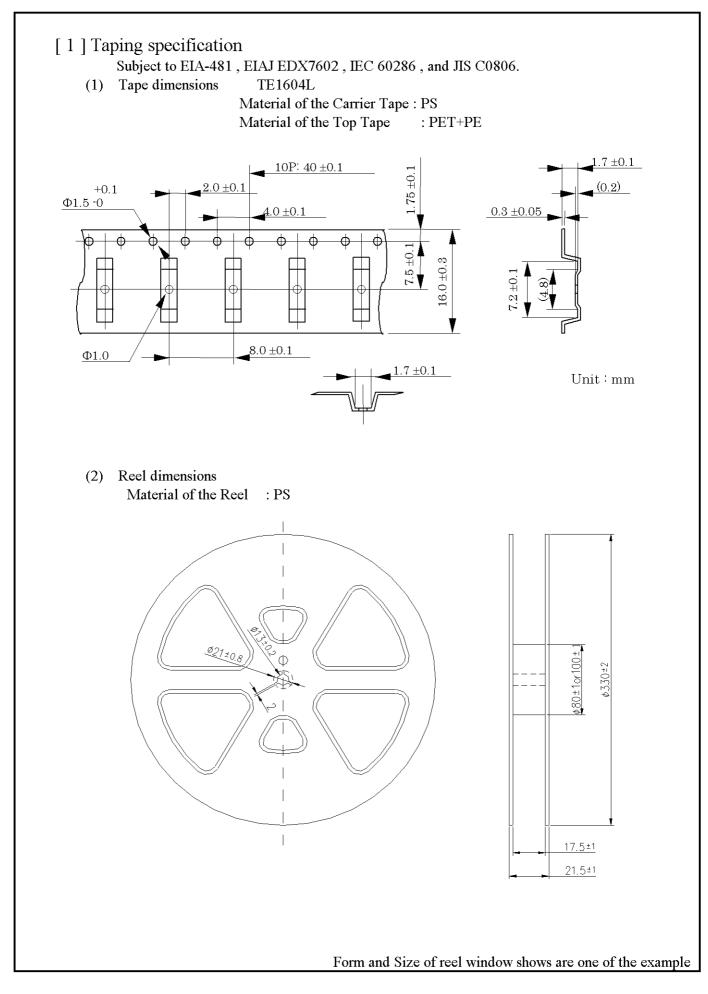
TAPING SPECIFICATION

1. APPLICATION

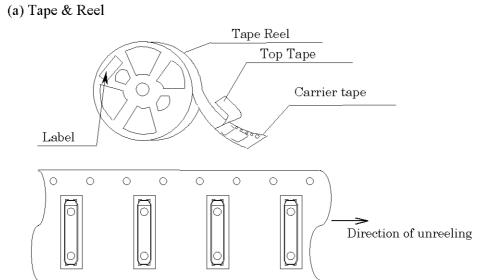
This document is applicable to MC-146.

2. CONTENTS

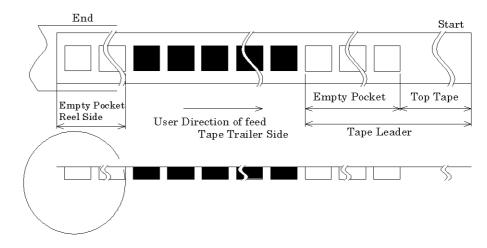
Item No.	Item	Page
[1]	Taping specification	1 to 2
[2]	Inner carton	3
[3]	Shipping carton	
[4]	Marking	4
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[6]	Storage environment	
[7]	Handling	



(3) Packing



(b) Start & End Point



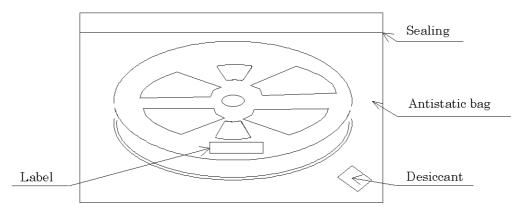
(c) Peel force of the cover tape

- (1) angle : cover tape during peel off and the direction of unreeling shall be 165° to 180° .
- (2) peel speed : 5 mm/s.

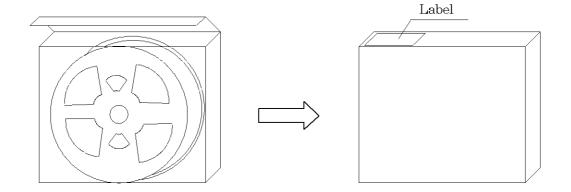
	ltem	Empty Space
Tape Leader	Тор Таре	Min. 1 000 mm
	Carrier Tape	Min. 40 pockets
Tape Trailer	Тор Таре	Min. 0 mm
	Carrier Tape	Min. 40 pockets

[2] Inner Carton

a) Packing to antistatic bag

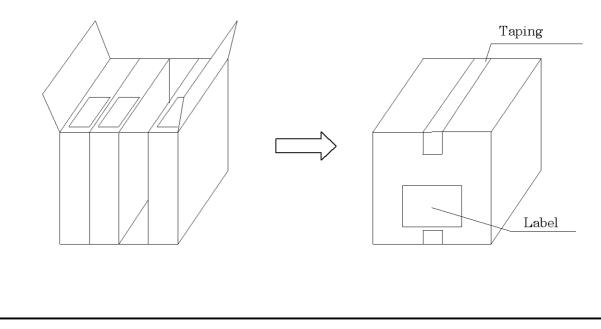


b) Packing to innercarton



[3] Shipping Carton

- Put inner boxes into an outer box.
- If there are room in the outer box, material is put in a shock absorbing together.



[4] Marking

- (1) Reel marking
 - Reel marking shall consist of :
 - 1) Parts name
 - 2) Quantity
 - 3) Manufacturing Date or symbol
 - 4) Manufacturer's Date or symbol
 - 5) Others (if necessary)
- (2) Inner carton marking
 - Same as Reel marking.
- (3) Shipping carton marking
 - Shipping carton marking shall consist of :
 - 1) Parts name
 - 2) Quantity

[5] Quantity

• 3 000 pcs./reel

[6] Storage environment

- (1) To storage the reel at +15 $^{\circ}$ C to +35 $^{\circ}$ C, 25 %RH to 85 %RH of Humidity.
- (2) To open the packing just before using.
- (3) Not to expose the sun.
- (4) Not to storage with some erosive chemicals.
- (5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

[7] Handling

To handle with care to prevent the damage of tape, reel and products.

- PROCESS QUALITY CONTROL -

(SIO2 COATING) D FRAME INCOMING INSPECTION (Sub-4)	SECTION SPECIFICAT YSIA PLANT PURCHASING SPECIFICATI Contractor) YSIA PLANT YSIA PLANT MANUFACTURING INSTRUC Contractor) MANUFACTURING INSTRUC YSIA PLANT MANUFACTURING INSTRUC Contractor) MANUFACTURING INSTRUC YSIA PLANT MANUFACTURING INSTRUC Contractor) YSIA PLANT YSIA PLANT SOLDER PLATING Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC	ON APPEARANCE TION SHEET APPEARANCE TION SHEET DIMENSION TION SHEET APPEARANCE TION SHEET APPEARANCE S.P THICKNESS APPEARANCE	METHOD METHOD SAMPLING SAMPLING SAMPLING SAMPLING SAMPLING SAMPLING SAMPLING SAMPLING	INSTRUMENTS MICROSCOPE T.M.S VISUAL INSPECTION MICROSCOPE FLUOROSCOPY VISUAL INSPECTION	COLLECTION IN-COMING INSPECTION PROCESS DATA SHEET
(SIO2 COATIING) FRAME INCOMING INSPECTION 2 MALAY (Sub-4 3 MALAY (Sub-4 4 MALAY (Sub-4 4 MALAY (Sub-4 5 MALAY (Sub-4 4 MALAY (Sub-4 5 MALAY (Sub-4 4 MALAY (Sub-4 5 MALAY (Sub-4 4 MALAY (Sub-4 5 MALAY (Sub-4 6 MALAY (Sub-4 6 MALAY (Sub-4 7 MALAY (Sub-4 (Sub-4 7 MALAY (Sub-4 (Contractor) VSIA PLANT MANUFACTURING INSTRUC Contractor) MANUFACTURING INSTRUC VSIA PLANT MANUFACTURING INSTRUC Contractor) VSIA PLANT SOLDER PLATING Contractor) SPECIFICATION SHEET VSIA PLANT MANUFACTURING INSTRUC Contractor)	TION SHEET APPEARANCE TION SHEET DIMENSION TION SHEET APPEARANCE TION SHEET APPEARANCE S.P THICKNESS APPEARANCE	SAMPLING SAMPLING SAMPLING SAMPLING SAMPLING SAMPLING	MICROSCOPE T.M.S VISUAL INSPECTION MICROSCOPE FLUOROSCOPY	PROCESS DATA SHEET PROCESS DATA SHEET PROCESS DATA SHEET PROCESS DATA SHEET PROCESS DATA SHEET
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INCOMING 3 MALA' INSPECTION 4 MALA' (Sub-4) 4 MALA' (Sub-4) 5 MALA' (Sub-4) 5 MALA' (Sub-4) 5 MALA' (Sub-4) 6 MALA' (Sub-4) 4 1st PRESSING	YSIA PLANT MANUFACTURING INSTRUC Contractor) YSIA PLANT MANUFACTURING INSTRUC Contractor) YSIA PLANT SOLDER PLATING Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC Contractor)	TION SHEET APPEARANCE TION SHEET APPEARANCE S.P THICKNESS APPEARANCE	SAMPLING SAMPLING SAMPLING SAMPLING	VISUAL INSPECTION MICROSCOPE FLUOROSCOPY	PROCESS DATA SHEET PROCESS DATA SHEET PROCESS DATA SHEET
INSPECTION (Sub-(4 MALA' (Sub-(2 CRYSTAL WELDING 3 TRANSFER MOULDING 4 Ist PRESSING 7 MALA'	Contractor) YSIA PLANT MANUFACTURING INSTRUC Contractor) YSIA PLANT SOLDER PLATING Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC Contractor)	TION SHEET APPEARANCE S.P THICKNESS APPEARANCE	SAMPLING SAMPLING SAMPLING	MICROSCOPE	PROCESS DATA SHEET
2 CRYSTAL WELDING 5 MALA 3 TRANSFER MOULDING 6 MALA 4 1st PRESSING 7 MALA	Contractor) YSIA PLANT SOLDER PLATING Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC Contractor)	S.P THICKNESS APPEARANCE	SAMPLING SAMPLING	FLUOROSCOPY	PROCESS DATA SHEET
3 TRANSFER MOULDING 6 MALA 4 1st PRESSING 7 MALA	Contractor) SPECIFICATION SHEET YSIA PLANT MANUFACTURING INSTRUC Contractor)	APPEARANCE	SAMPLING		
3 TRANSFER MOULDING 6 MALA (Sub-4) 4 1st PRESSING 7 MALA	YSIA PLANT MANUFACTURING INSTRUC Contractor)			VISUAL INSPECTION	PROCESS DATA SHEET
4 1st PRESSING 7 MALA	Contractor)	TION SHEET APPEARANCE	SAMPLING		I ROOLOG DATA ONCE
Ý				VISUAL INSPECTION	PROCESS DATA SHEET
(Sub.)	I SIM CLAINT MINNUFACTURING INSTRUC	TION APPEARANCE	SAMPLING	MICROSCOPE	PROCESS DATA SHEET
1	Contractor)	DIMENSION	SAMPLING	VERTICAL COMPARATOR	PROCESS DATA SHEET
5 SOLDER PLATING 8 MALA	YSIA PLANT MANUFACTURING INSTRUC	TION SHEET ELECTRICAL CHARACTERISTIC	100% INSPECTION	T0 CHECKING By m/c	PROCESS DATA SHEET
(Sub-(Contractor) MANUFACTURING INSTRUC	TION SHEET TAPING STRENGTH	SAMPLING	PEEL BACK TESTER	PROCESS DATA SHEET
(6) MARKING	QUALITY STD.	ELECTRICAL CHARACTERISTIC	SAMPLING	T0&CI CHECKER	OGI INSP.SHEET
Y	YSIA PLANT QUALITY STD.	APPEARANCE	SAMPLING	MICROSCOPE	OGI INSP.SHEET
FINAL INSPECTION 10-1 MALA	YSIA PLANT MANUFACTURING INSTRUC	TION SHEET EXPORT CUSTOMER LIST			EXPORT DOCUMENTS
AND TAPING (Sub-C	Contractor) DAILY SHIPPING LIST	FREQUENCY			
		QUANTITY			
10-2 MALA	YSIA PIANT MANUFACTURING INSTRUC	TION SHEET EXPORT CUSTOMER LIST			EXPORT DOCUMENTS
(10-1) Pre-PACKING	DAILY SHIPPING LIST	FREQUENCY			
		QUANTITY			

- PROCESS QUALITY CONTROL -

			RESPONSIBLE	STANDARD AND	INSPECTION AND	INSPECTION	U Sandrage VI	DATA
MANUFACTURING PRO	CESS CHART	No	SECTION	SPECIFICATIONS	CONTROL ITEMS	METHORD	INSTRUMENTS	COLLECTION
CRYSTA (SiO2 COAT		1'	SUB-CONTRACTOR	PURCHASING SPECIFICATION	APPEARANCE	SAMPLING	MICROSCOPE	IN-COMING INSPECTION
		2	SUB-CONTRACTOR	MANUFACTURING INSTRUCTION SHEET MANUFACTURING INSTRUCTION SHEET	APPEARANCE DIMENSION	SAMPLING SAMPLING	MICROSCOPE T.M.S	PROCESS DATA SHEET PROCESS DATA SHEET
		3	SUB-CONTRACTOR	MANUFACTURING INSTRUCTION SHEET	APPEARANCE	SAMPLING	VISUAL INSPECTION	PROCESS DATA SHEET
		4	SUB-CONTRACTOR	MANUFACTURING INSTRUCTION SHEET	APPEARANCE	SAMPLING	MICROSCOPE	PROCESS DATA SHEET
2	CRYSTAL WELDING	5	SUB-CONTRACTOR	SOLDER PLATING SPECIFICATION SHEET	S.P THICKNESS	SAMPLING SAMPLING	FLUOROSCOPY VISUAL INSPECTION	PROCESS DATA SHEET PROCESS DATA SHEET
(3)	TRANSFER MOULDING	6	SUB-CONTRACTOR	MANUFACTURING INSTRUCTION SHEET	APPEARANCE	SAMPLING	VISUAL INSPECTION	PROCESS DATA SHEET
Ĭ	1st PRESSING		SUB-CONTRACTOR	MANUFACTURING INSTRUCTION	APPEARANCE DIMENSION	SAMPLING SAMPLING	MICROSCOPE VERTICAL COMPARATOR	PROCESS DATA SHEET
Ý		8	SUB-CONTRACTOR	MANUFACTURING INSTRUCTION SHEET		100% INSPECTION	F0 CHECKING By m/c	PROCESS DATA SHEET
(5)	SOLDER PLATING	-		MANUFACTURING INSTRUCTION SHEET	TAPING STRENGTH	SAMPLING	PEEL BACK TESTER	PROCESS DATA SHEET
Ý				QUALITY STD,	ELECTRICAL CHARACTERISTIC	SAMPLING	T0&CI CHECKER	OGI INSP.SHEET
(6)	MARKING	9	SUB-CONTRACTOR	QUALITY STD.	APPEARANCE	SAMPLING	MICROSCOPE	OGI INSP.SHEET
	2nd PRESS	10-1	SUB-CONTRACTOR	MANUFACTURING INSTRUCTION SHEET DAILY SHIPPING LIST	EXPORT CUSTOMER LIST FREQUENCY QUANTITY			EXPORT DOCUMENTS
8	FINAL INSPECTION	10-2	INA PIANT	MANUFACTURING INSTRUCTION SHEET	EXPORT CUSTOMER LIST			EXPORT DOCUMENTS
	AND TAPING			DAILY SHIPPING LIST	FREQUENCY			
(S)	OUTGOING INSPECTION		1		QUANTITY			

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- PROCESS QUALITY CONTROL -

No

CODE : MC-146

Control No : M-9803-AKE-1

MANUFACTURING PROCESS CHART

RESPONSIBLE STANDARD AND INSPECTION AND INSPECTION MEASURING SECTION SPECIFICATIONS CONTROL ITEMS METHORD INSTRUMENTS PURCHASING SPECIFICATION APPEARANCE SAMPLING PIUG GAUGES INCOMING INSPECTION STD. DIMENSION MICROSCOPE MANUFACTURING INSTRUCTION SHEET APPEARANCE 100% INSPECTION MICROSCOPE MANUFACTURING INSTRUCTION SHEET DIMENSION SAMPLING T.M.S MANUFACTURING INSTRUCTION SHEET STRENGTH SAMPLING PUSH&PULL GAUGE APPEARANCE MANUFACTURING INSTRUCTION SHEET 100% INSPECTION MICROSCOPE SAMPLING MANUFACTURING INSTRUCTION SHEET APPEARANCE SAMPLING MICROSCOPE SOLDER PLATING S.P THICKNESS SAMPLING FLUOROSCOPY SPECIFICATION SHEET APPEARANCE SAMPLING VISUAL INSPECTION MANUFACTURING INSTRUCTION SHEET APPEARANCE SAMPLING VISUAL INSPECTION MANUFACTURING INSTRUCTION APPEARANCE SAMPLING MICROSCOPE DIMENSION SAMPLING INSPECTION JIG MANUFACTURING INSTRUCTION SHEET ELECTRICAL CHARACTERISTIC 100% INSPECTION F0 CHECKING By m/c MANUFACTURING INSTRUCTION SHEET TAPING STRENGTH SAMPLING STRENGTH TESTER

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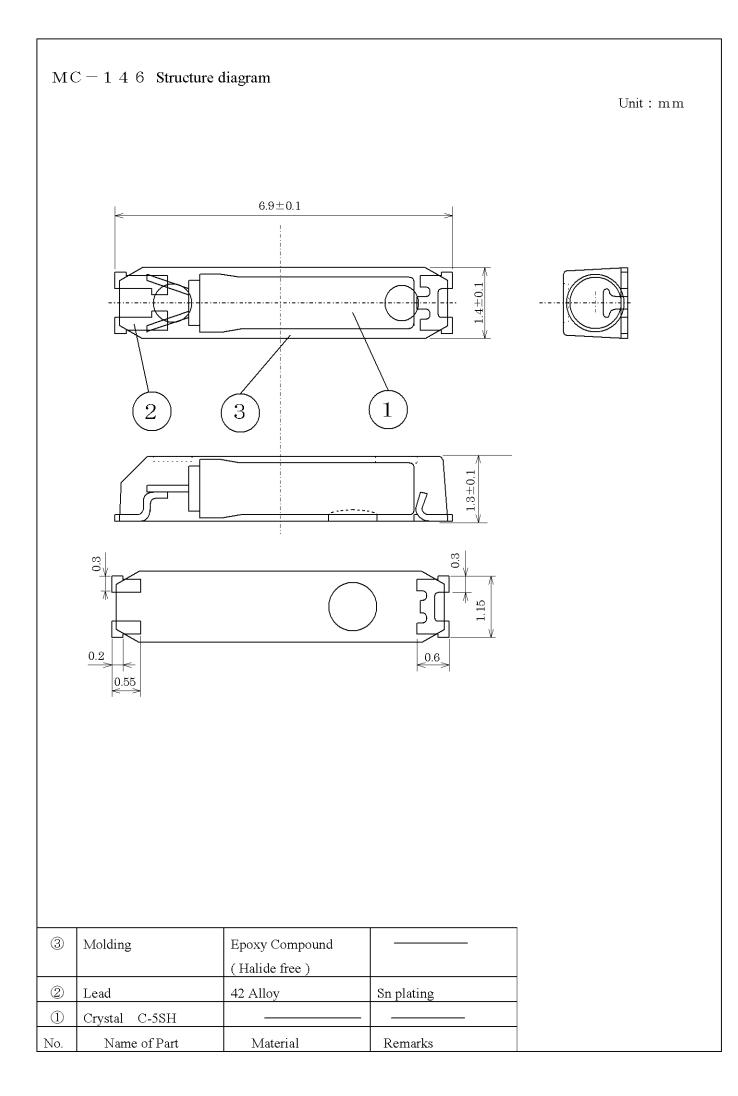
EPSON TOYOCOM CORP.

PREPARED CHECKED APPROVED

h. hugan h happin

DATA

COLLECTION 13 SUB-CONTRACTOR CRYSTAL IN-COMMING INSPECTION (SIO2 COATING) DATA SHEET LEAD FRAME 2 SUB-CONTRACTOR PROCESS DATA SHEET PROCESS DATA SHEET INCOMING 1' PROCESS DATA SHEET INSPECTION 3 SUB-CONTRACTOR PROCESS DATA SHEET PROCESS DATA SHEET 4 SUB-CONTRACTOR PROCESS DATA SHEET 2 CRYSTAL WELDING 5 SUB-CONTRACTOR PROCESS DATA SHEET SUB-CONTRACTOR PROCESS DATA SHEET 3 TRANSFER MOULDING 6 SUB-CONTRACTOR PROCESS DATA SHEET 7 SUB-CONTRACTOR PROCESS DATA SHEET 4 1st PRESSING PROCESS DATA SHEET 8 SUB-CONTRACTOR PROCESS DATA SHEET 5 SOLDER PLATING PROCESS DATA SHEET QUALITY STD. ELECTRICAL CHARACTERISTIC SAMPLING TO&CI CHECKER OGI INSP.SHEET 6 9 SUB-CONTRACTOR QUALITY STD. MARKING APPEARANCE SAMPLING MICROSCOPE OGI INSP.SHEET MANUFACTURING INSTRUCTION SHEET 10 SUB-CONTRACTOR EXPORT CUSTOMER LIST EXPORT DOCUMENTS 7 2nd PRESS DAILY SHIPPING LIST FREQUENCY QUANTITY FINAL INSPECTION AND TAPING <u>(</u> 9) OUTGOING INSPECTION (10) PACKING EXPORT



EPSON TOYOCOM

RELIABILITY TEST DATA

Product Name : MC-146 (Halide free mold)

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition . No. F-M-980301-05-001EH

			VALUE *1 *2	TEST	FAIL
No.	ITEM	TEST CONDITIONS	$\Delta f/f$	Qty	Qty
L			$[1 \times 10^{-6}]$	[n]	[n]
1	Shock	100 g dummy (ETC Standard) drop from 1 500 mm height on to the concrete 3 directions 10 times	*3 ± 5	22	0
2	Vibration	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz \rightarrow 500 Hz \rightarrow 10 Hz 15 min / cycle 6 h (2 h × 3 directions)	*3 ± 3	22	0
3	Resistance to soldering heat	For convention reflow soldering furnace (2 times) The measurement is after 24 h	± 5	22	0
4	High temperature storage	a) +125℃× 1 000 h b) +85 ℃× 1 000 h	*3 a) ± 20 *3 b) ± 10	a) 22 b) 22	a) 0 b) 0
5	Low temperature storage	-55 °C×1 000 h	*3 ± 10	22	0
6	Temperature humidity storage	+85 °C× 85 %RH × 1 000 h	*3 ± 10	22	0
7	Temperature cycle	$-55 \ ^{\circ}C \Leftrightarrow +125 \ ^{\circ}C$ 30 min at each temp. 100 cycles	*3 ± 10	22	0
8	Shear	10 N press for 10 s \pm 1 s Ref. IEC 60068-2-21	No peeling - off at a solder part	22	0
9	Pull - off	10 N press for 10 s ± 1 s Ref. IEC 60068-2-21	No peeling - off at a solder part	22	0
10	Substrate bending	Bend width reaches 3 mm and hold for 5 s \pm 1 s \times 1 time Ref. IEC 60068-2-21	No peeling - off at a solder part	22	0
11	Solderability	Dip termination into solder bath at +235 $^{\circ}C \pm 10 ^{\circ}C$ for 3 s (Using Rosin Flux)	Termination must be 95 % covered with fresh solder	11	0
12	Solvent resistance	Ref. JIS C 0052 or IEC 60068-2-45	The marking shall be legible	11	0

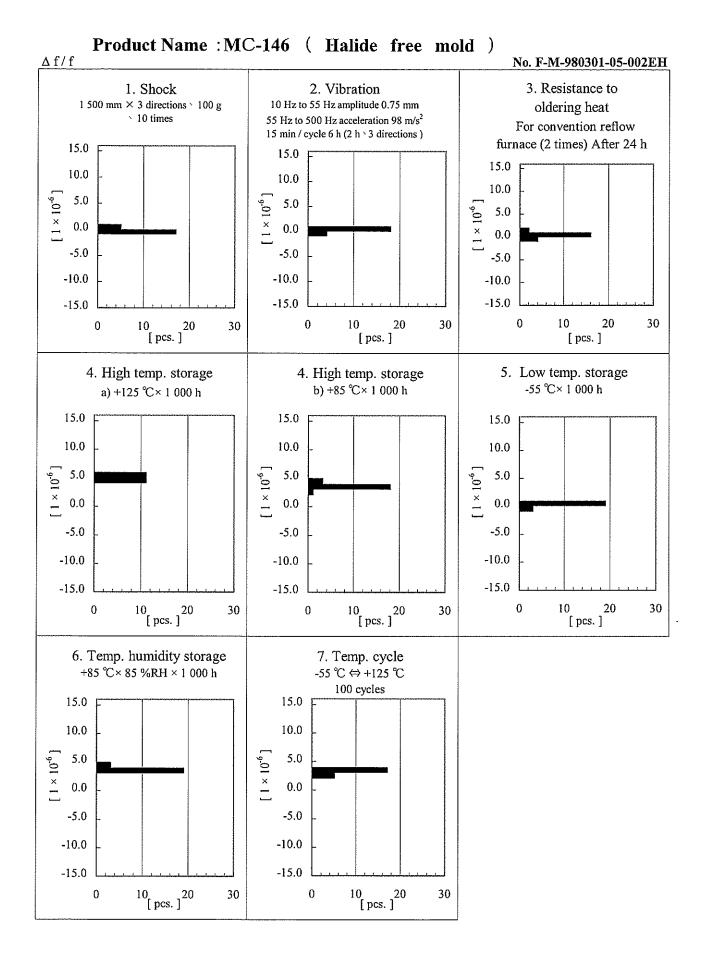
Notes

- 1. *1 Each test done independently.
- 2. *2 Measuring 1 h to 24 h later leaving in room temperature after each test.
- 3. *3 Pre conditionings Initial value shall be after 24 h at room temperature.
- 4. Shift series resistance at after above tests should be less than ±15 % or less than ±5 kΩ. In case Resistance to soldering heat, high temperature storage (+125 °C × 1 000 h) shift series resistance at after above tests should be less than ±20 % or less than ±10 kΩ.

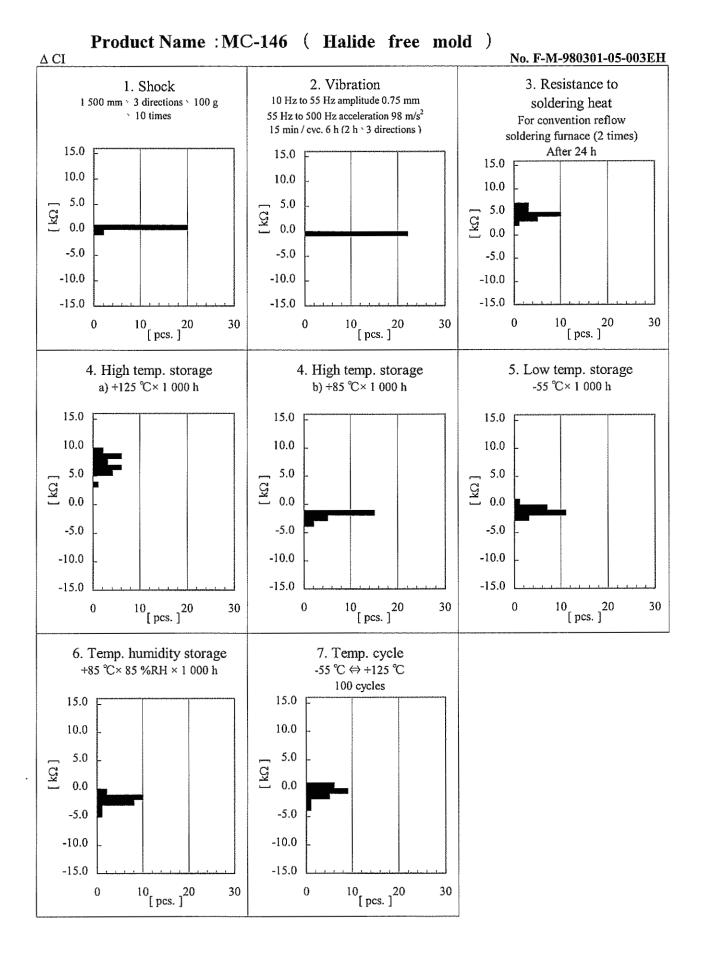
Signature

Approved

Jun Watanuki / General Manager of QZ Business unit Quality Assurance



Qualification Data



Qualification Data

单击下面可查看定价,库存,交付和生命周期等信息

>>Epson(爱普生)